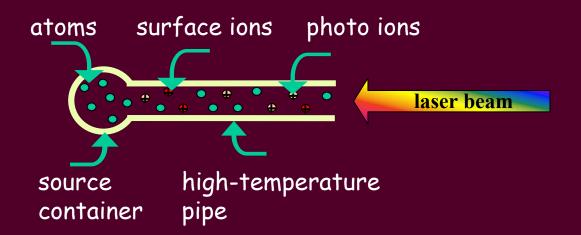
# IMPROVEMENTS in the RILIS SELECTIVITY and SPECTRAL RESOLUTION by the use of TIME-OF-FLIGHT TECHNIQUES

V. I. Mishin

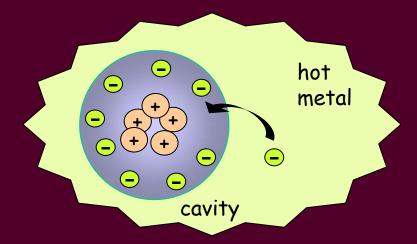
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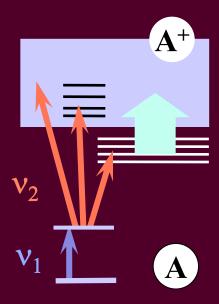
### Operation of RILIS

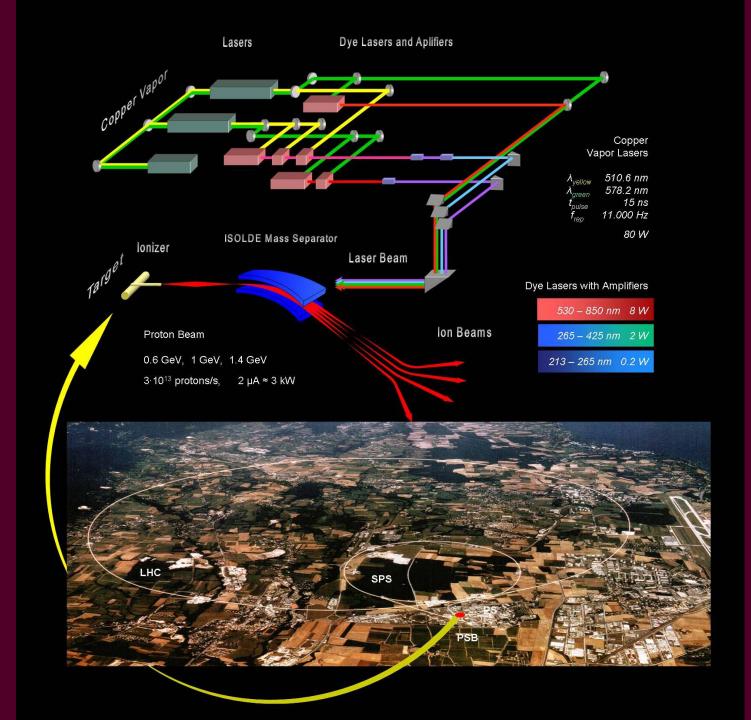


TRAPPING
of IONS
by CAVITY
PLASMA



RESONANT LASER
IONIZATION
of ATOMS





# A collection of the RILIS critical parameters

- Universality: most part of the periodic table elements can be ionized
- \* High ionization efficiency for isotopes and nuclear isomers
- \* High ionization selectivity for isobars, isotopes and nuclear isomers
- In-source laser spectroscopy: study of radioactive atoms with ultra-high sensitivity
- Fast changing of ion beam structure: isobaric or isomeric
- In-source preparation of polarized nuclear: in the future
- Simplicity of RILIS components are placed in the radioactive region low servicing costs for RILIS over a plasma ion source if high current proton beams are used

#### Selectivity of RILIS

Two basic factors define the RILIS selectivity:

LASER IONIZATION of studied (wanted) atoms and

SURFACE IONIZATION of interfering (unwanted) atoms

#### Surface Ionization of Atoms

$$\alpha_{s} = \frac{n_{is}}{n_{os}} \approx \exp(\frac{\varphi - W_{i}}{kT})$$

Langmuir equation

 $\mathbf{W_i}$  - the ionization potential of atoms

 $\phi$  - the work function of the electron emitting surface

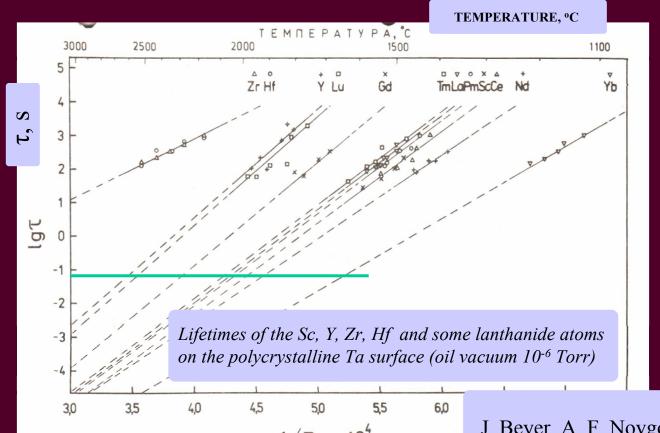
#### Wall sticking times

$$\tau_{sorp} = \tau_0 \exp(-\frac{E_d}{kT})$$

Frenkel equation

 $1/\tau_0$  – frequency factor

 $E_{\rm d}$  – interaction energy of the atom with the surface



The number of collisions of the atom with a wall of the RILIS ionizer prior to it fly out is

$$N = \frac{S_{wall} = \pi DL}{S_{hole} = \pi D^2/4} = 4L/D$$

L = 3 cm, D = 3 mm (length and diameter of the ionizer)

$$N = 40$$

J. Beyer, A. F. Novgorodov and V. A. Halkin. JINR preprint P6 – 9917, 1976

Selectivity of RILIS can be increased considerably providing laser produced ions are separated from thermal ions



Maximum RILIS selectivity, which can be reached by laser ions separation from thermal ions, is equal to

$$S = T / \tau_{ions}$$

$$\mathbf{f}_{\text{laser}} = 10^4 \text{ pps}$$

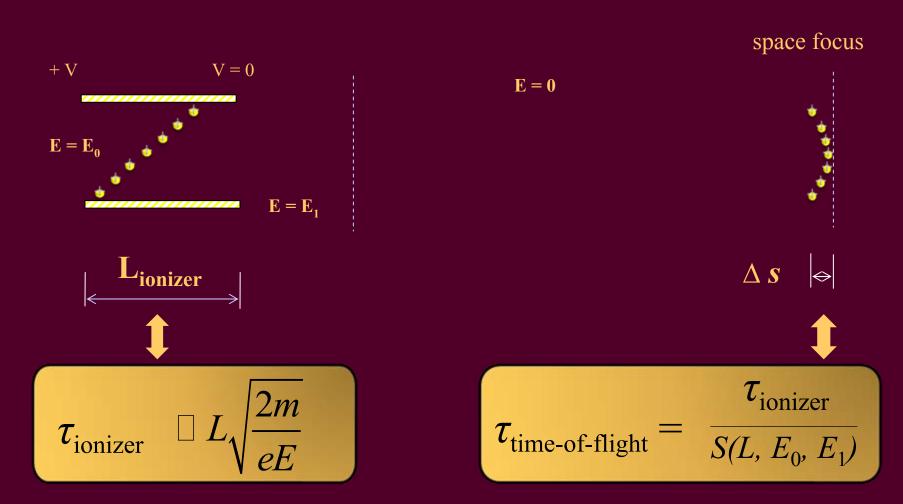
$$\mathbf{T} = 1/\mathbf{f}_{\text{laser}} = 100 \text{ µs}$$

$$\mathbf{\tau}_{\text{ions}} = \mathbf{\tau}_{\text{laser}} \approx 10 \text{ ns}$$

S≈10000

It makes sense to hunt for this number

# Time-of-flight compression of RILIS ion pulses

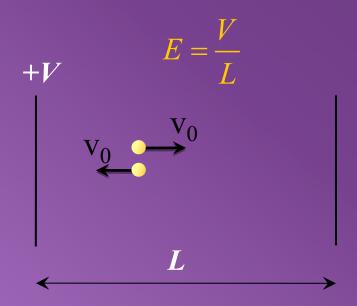


### Ion peak width

 $au_{ ext{ion peak}} pprox au_{ ext{spatial distribution}} + au_{ ext{turn-around}}$ 

# Broadening of ion pulses by initial thermal energy distributions of ions

acceleration region

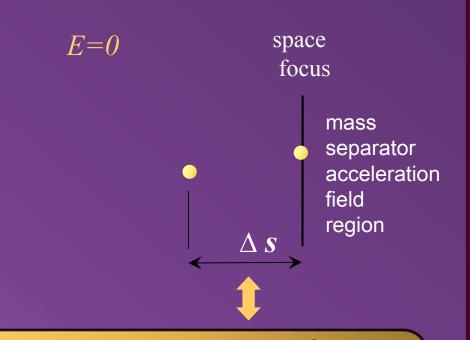


**V**<sub>0</sub> - initial thermal velocity

*m* - mass of ions

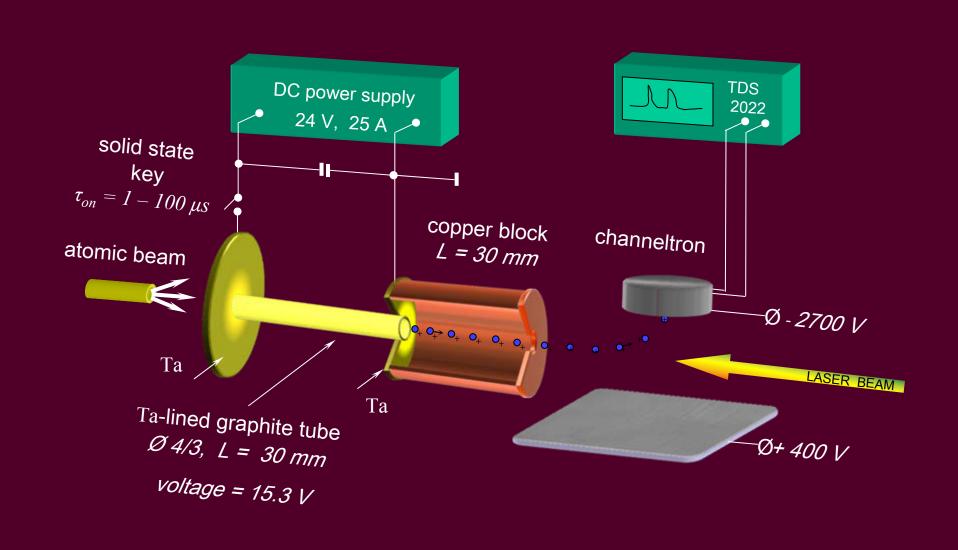
**e** - charge of electron

field free drift-region

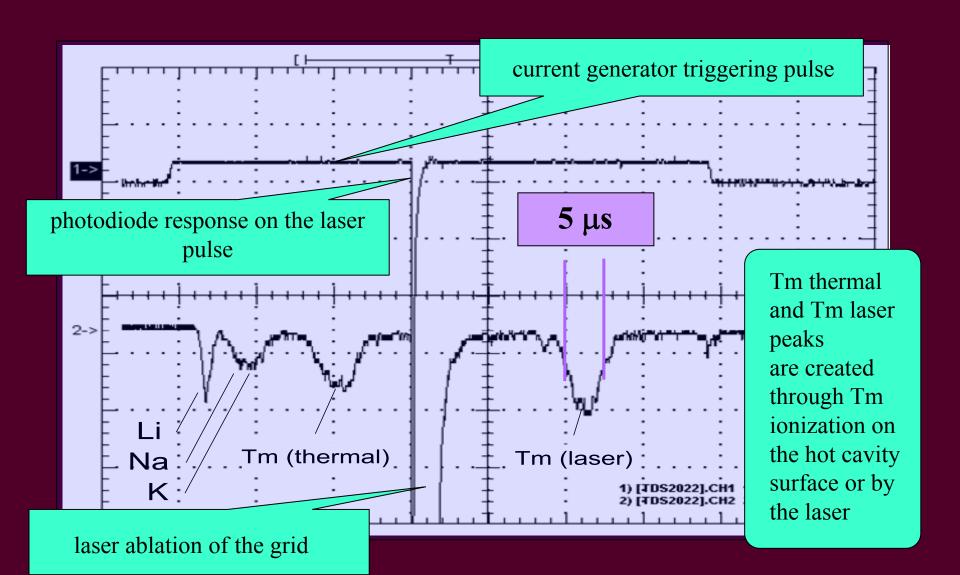


$$\tau_{\text{turn-around time}} = \frac{2v_0 m}{eE}$$

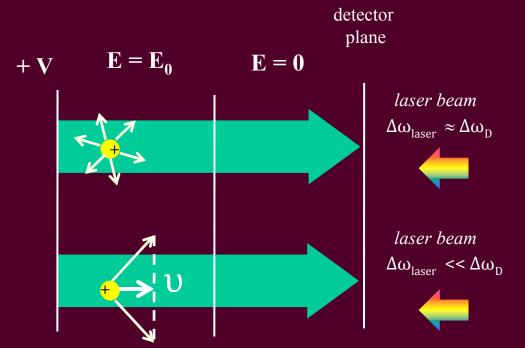
### Experimental Setup

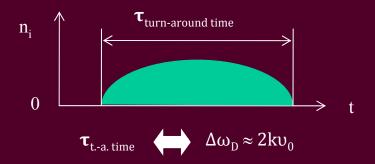


### Time-of-flight mass spectrum of Li, Na, K and Tm



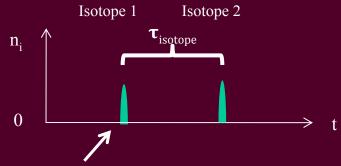
### Subdoppler Velocity Selective Resonance Ionization Spectroscopy





The laser frequency is fixed

$$\omega_{laser} - \omega_1 = k \upsilon_1$$
  $\omega_{laser} - \omega_2 = k \upsilon_2$ 



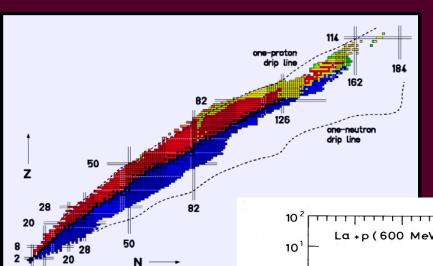
- The duration of the ion peak  $\tau_{ion}$  corresponds to the laser line width  $\Delta\omega_{laser}$ 
  - The time interval between the ion peaks  $\tau_{\rm isotope}$  corresponds to the isotope shift  $\Delta\omega_{\rm isotope}$

 $\omega - \omega_0 = kv$ 

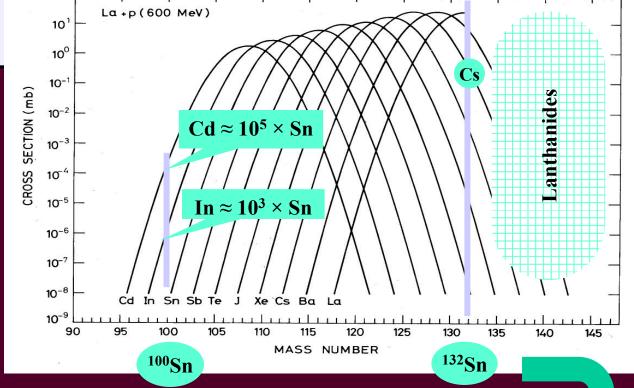
 $k = \omega/c$  v is the velocity projection onto the laser axis

#### Conclusions

- The Resonant Ionization Laser Ion Source, RILIS, can operate in the time-of-flight mode
- RILIS operating in the time-of-flight mode has the length rather small,  $\approx 60$  mm. Therefore it can be installed in front of the mass-separator
- For Sn it is possible to obtain the ion pulses with duration below 4 μs down to 500 ns
- Selectivity of ISOLDE-RILIS of Sn can be increased by a factor of 25 or more applying this time-of-flight technique

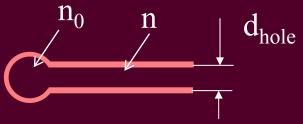


# The need for selectivity



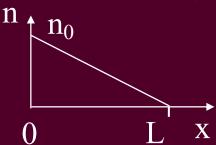
Spallation of La with 0.6 GeV protons

### Efficiency of RILIS



outgoing flow of atoms

$$J_{atoms} = \frac{1}{3} (d_{hole}/L) n_0 v_0 S_{hole}$$



outgoing flow of ions

$$J_{ions} = \frac{1}{2} LS_{hole} n_0 f \times \eta_{phot.} \times \eta_{conf.} \times \eta_{...} \times \eta_{...}$$

$$\eta_{
m RILIS} pprox \ \ rac{
m J_{ions}}{
m J_{atoms}} =$$

$$\eta_{RILIS} \approx \frac{J_{ions}}{J_{atoms}} = \frac{3}{2} (L^2 f/v_0 d_{hole}) \times \eta_{phot.} \, \eta_{conf.} \dots$$

is cavity amplification factor M

is cavity length (3 cm)

is cavity diameter (3 mm)

is isotope density

is thermal velocity of isotopes (≈ 10<sup>5</sup> cm/s)

is laser pulse repetition rate (10<sup>4</sup> pps)

 $\eta_{conf.}$  is efficiency of ions confinement by thermal plasma  $\eta_{\text{phot.}}$  is efficiency of laser photoionization  $\eta_{RILIS}$  is efficiency of RILIS

#### Efficiency of RILIS

$$\begin{array}{c} M=5 \\ \eta_{\text{photoionization}} = 0.2 \\ \eta_{\text{confinement}} = 1 \end{array} \qquad \begin{array}{c} \eta_{\text{RILIS}} = 100\% \\ \end{array}$$

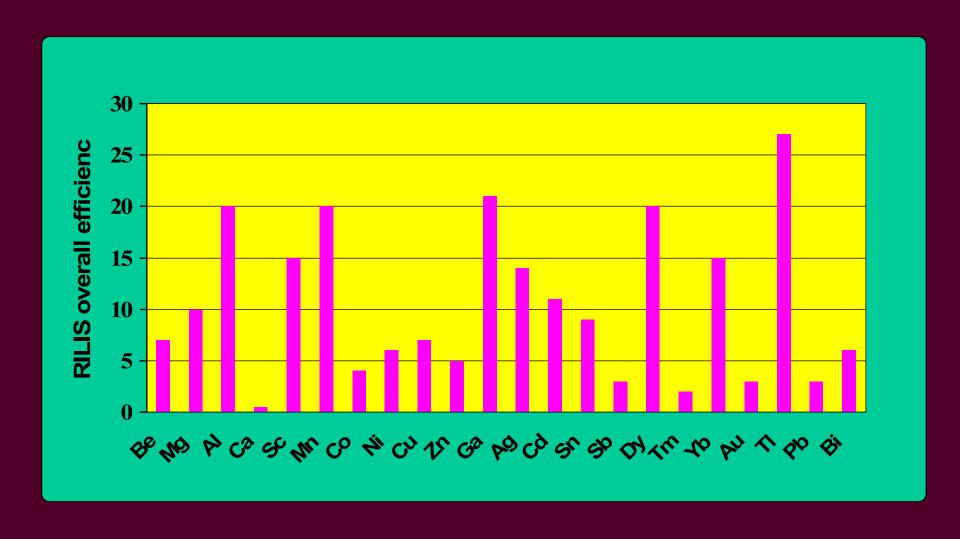
#### **EXPERIMENT**

$$\eta_{\text{RILIS}}$$
 (T1)  $\approx 30\%$  (ISOLDE, L = 3cm)
$$\eta_{\text{RILIS}}$$
 (Ho)  $\approx 40\%$  (HRIBF, L = 8 cm)

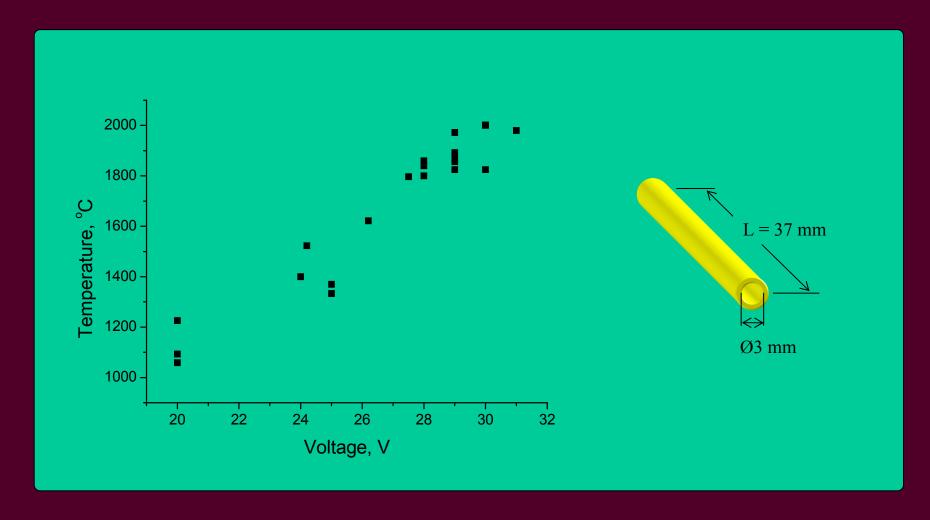
A higher approximation is

$$\eta_{RILIS} pprox rac{J_{ions}}{J_{ions} + J_{atoms}}$$

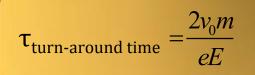
### Overall RILIS efficiencies for elements available at ISOLDE

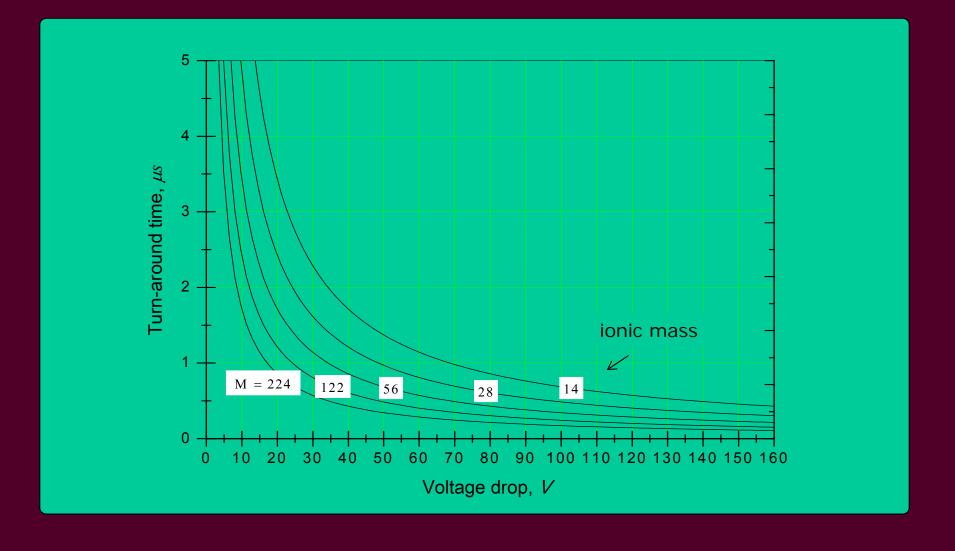


The plot shows the temperature of a graphite pipe in relation to the voltage drop produced by the DC current



The plot shows the turn-around time in relation to the voltage drop across the RILIS ionizer (L = 30 mm)





#### OVERVIEW of CHEMICAL ELEMENTS

which are available with RILIS,
which have been ionized by the use of high pulse repetition rate frequency-tuned lasers,
which can be ionized by the use of high pulse repetition rate frequency-tuned lasers,
which may be ionized by the use of high pulse repetition rate frequency-tuned lasers
following atomic level structure identification

